Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/944,200	BRADSHAW ET AL.	
Examiner	Art Unit	
John P. Lacyk	3736	

John P. Lacyk

	SEAR	CHED	
Class	Subclass	Date	Examiner
600	1-8		
604	194,		
	101.01,		
	103.06-		
	103.08	9/30/2005	JPL
Updated	above	7/9/2006	JPL

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			-

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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